



Description

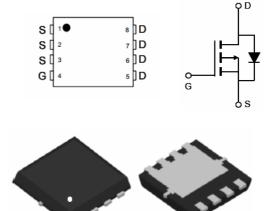
The XPX7403RX uses advanced trench technology to provide excellent $R_{DS(ON)}$, This device is suitable for use as a load switch or power management.

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

Application

- Power management
- Load switch

 $V_{DS} = -30V, I_{D} = -32A$ $R_{DS}(ON) = 15m\Omega @ V_{GS} = -10V$ $R_{DS}(ON) = 24m\Omega @ V_{GS} = -4.5V$



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
7403	XPX7403RX	DFN3X3-8			

Absolute Maximum Ratings (T_A=25 ℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	-30	V
Gate-Source Voltage	V _G s	±25	V
Drain Current-Continuous	I _D	-32	Α
Drain Current-Pulsed (Note 1)	I _{DM}	-60	Α
Maximum Power Dissipation	P _D	40	W
Operating Junction and Storage Temperature Range	T_{J} , T_{STG}	-55 To 150	$^{\circ}\!\mathbb{C}$
Thermal Resistance, Junction-to-Case ^(Note 2)	R _{θJC}	2.2	°C/W



Absolute Maximum Ratings $(T_A = 25^{\circ}C \text{ Unless Otherwise Noted})$

Symbol	Parameter	Rating	Unit			
Common Ratings						
V _{DSS}	Drain-Source Voltage	-30	_ v			
V_{GSS}	Gate-Source Voltage	±25				
T_J	Maximum Junction Temperature	150				
T_{STG}	Storage Temperature Range	-55 to 150				
Is	Diode Continuous Forward Current	T _C =25°C	-16			
I _D	Continuous Drain Current	T _C =25°C	-32	A		
טי	Continuous Diairi Curient	T _C =100°C	-20	A		
I _{DM}	Pulsed Drain Current	T _C =25°C	-60 *			
P _D	Maximum Power Dissipation	T _C =25°C	29.8	W		
ט י		T _C =100°C	11.9	v		
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	4.2	°C/W		
I _D	Continuous Drain Current	T _A =25°C	-10.5 ^b	Α .		
ID.		T _A =70°C	-8.4 ^b	$\neg \land$		
P _D	Maximum Power Dissipation	T _A =25°C	3.1	W		
		T _A =70°C	2			
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	t ≤ 10s	40	- °C/W		
	The iniai ivesistance-Junction to Ambient	Steady State	75			
I _{AS} a	Avalanche Current, Single pulse	L=0.5mH	14	А		
E _{AS} ^a	Avalanche Energy, Single pulse	L=0.5mH	49	mJ		

Note *: Current limited by bond wire.

Note a : UIS tested and pulse width are limited by maximum junction temperature 150°C

(initial temperature $T_J = 25^{\circ}C$).

Note b: t < 10s.



Electrical Characteristics (T_A = 25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit	
Static Cha	aracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =-250μA	-30	-	-	V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-24V, V _{GS} =0V	-	-	-1		
		T _J =85°C	-	-	-30	μΑ	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{DS}=-250\mu A$	-1.3	-1.8	-2.3	V	
I _{GSS}	Gate Leakage Current	$V_{GS}=\pm 25V, V_{DS}=0V$	-	-	±10	μΑ	
D C	Drain Cause On atota Dagistana	V _{GS} =-10V, I _{DS} =-16A	-	15	19		
R _{DS(ON)} c	Drain-Source On-state Resistance	V _{GS} =-4.5V, I _{DS} =-8A	-	24	32	mΩ	
Diode Cha	Diode Characteristics						
V _{SD} ^c	Diode Forward Voltage	I _{SD} =-1A, V _{GS} =0V	-	-0.7	-1	V	
t _{rr} d	Reverse Recovery Time	1 404 11 /11 4004/	-	18	-	ns	
Q _{rr} d	Reverse Recovery Charge	I_{SD} =-16A, dI_{SD}/dt =100A/ μ s	-	9	-	nC	
Dynamic (Characteristics ^d			•			
R_g	Gate Resistance	V _{GS} =0V, V _{DS} =0V,F=1MHz	-	4	-	Ω	
C _{iss}	Input Capacitance	$V_{GS}=0V$,	-	1000	-	pF	
Coss	Output Capacitance	V _{DS} =-15V,	-	220	-		
C _{rss}	Reverse Transfer Capacitance	Frequency=1.0MHz	-	170	-		
t _{d(ON)}	Turn-on Delay Time		-	11.2	-		
t _r	Turn-on Rise Time	V_{DD} =-15V, R_{L} =15 Ω ,	-	10.6	-	200	
t _{d(OFF)}	Turn-off Delay Time	I_{DS} =-1A, V_{GEN} =-10V, R_{G} =6 Ω	-	37	-	ns	
t _f	Turn-off Fall Time		-	50	-		
Gate Char	ge Characteristics ^d			•			
Q_g	Total Gate Charge		-	20	-		
Q_{gs}	Gate-Source Charge	V _{DS} =-15V, V _{GS} =-10V, I _{DS} =-16A	-	1.1	-	nC	
Q_{gd}	Gate-Drain Charge	108-107	-	7.7	-		

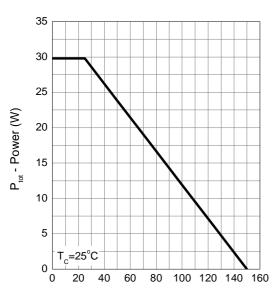
Note c : Pulse test ; pulse width \leq 300 μ s, duty cycle \leq 2%.

Note d: Guaranteed by design, not subject to production testing.



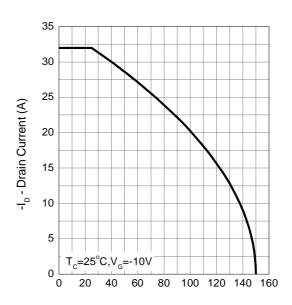
Typical Operating Characteristics

Power Dissipation



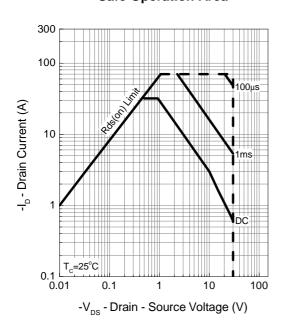
T_i - Junction Temperature (°C)

Drain Current

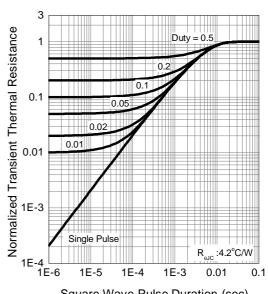


T_i - Junction Temperature (°C)

Safe Operation Area



Thermal Transient Impedance

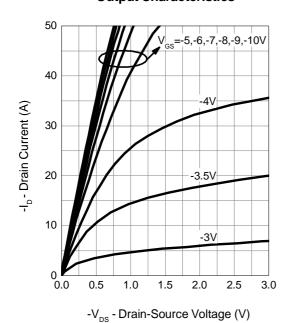


Square Wave Pulse Duration (sec)

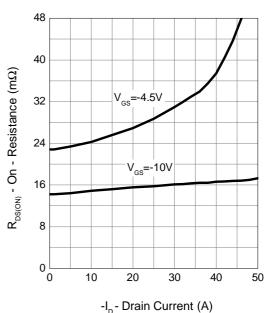


Typical Operating Characteristics (Cont.)

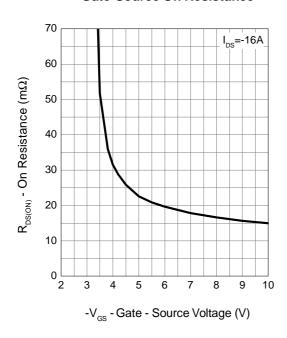
Output Characteristics



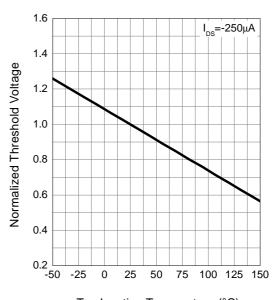
Drain-Source On Resistance



Gate-Source On Resistance



Gate Threshold Voltage

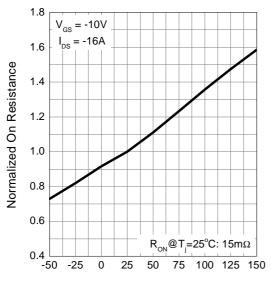


T_i - Junction Temperature (°C)



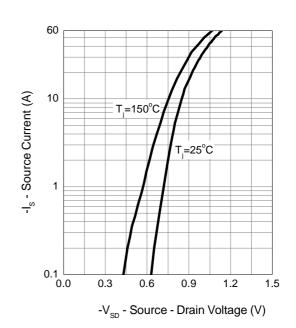
Typical Operating Characteristics (Cont.)

Drain-Source On Resistance

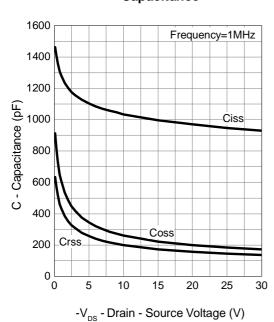


T_i - Junction Temperature (°C)

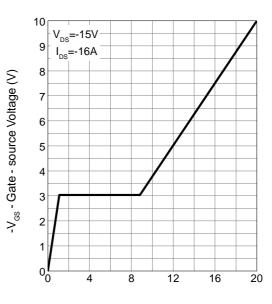
Source-Drain Diode Forward



Capacitance



Gate Charge

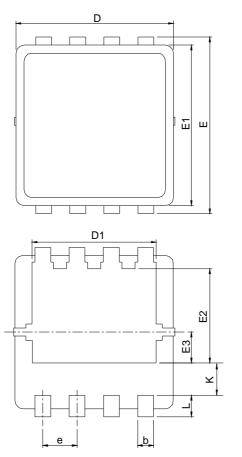


Q_G - Gate Charge (nC)



Package Information

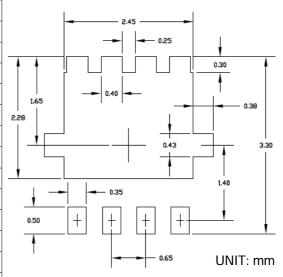
DFN3x3-8





Ş	DFN3x3-8				
SYMBOL	MILLIMETERS		INC	HES	
6	MIN.	MAX.	MIN.	MAX.	
Α	0.80	1.00	0.031	0.039	
A1	0.00	0.05	0.000	0.002	
А3	0.10	0.25	0.004	0.010	
b	0.24	0.35	0.009	0.014	
D	2.90	3.10	0.114	0.122	
D1	2.25	2.45	0.089	0.096	
Е	3.10	3.30	0.122	0.130	
E1	2.90	3.10	0.114	0.122	
E2	1.65	1.85	0.065	0.073	
E3	0.56	0.58	0.022	0.023	
е	0.65 BSC		0.026 BSC		
K	0.475	0.775	0.019	0.031	
L	0.30	0.50	0.012	0.020	

RECOMMENDED LAND PATTERN





Product	Peak Temperature	Dipping Time
Pb device	245 ℃ ±5 ℃	5sec±1sec
Pb-Free device	260℃+0/-5℃	5sec±1sec



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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